

RoHS Compliant Product  
A suffix of "-C" specifies halogen & lead-free

## DESCRIPTION

The SGM0410-C is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The SGM0410-C meet the RoHS and Green Product requirement with full function reliability approved.

## FEATURES

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Green Device Available

## MARKING



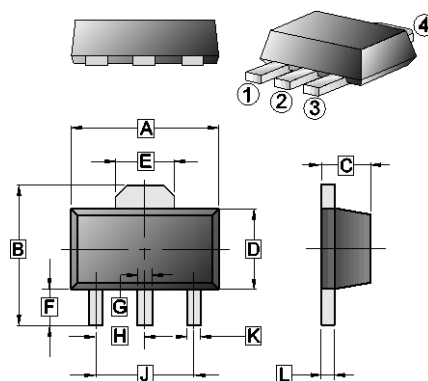
## PACKAGE INFORMATION

Package	MPQ	Leader Size
SOT-89	1K	7 inch

## ORDER INFORMATION

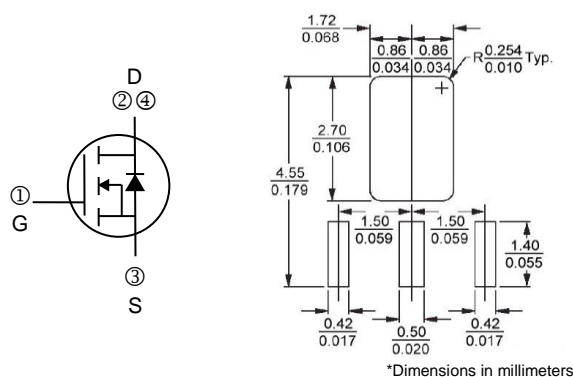
Part Number	Type
SGM0410-C	Lead (Pb)-free and Halogen-free

## SOT-89



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	4.40	4.60	G	0.40	0.58
B	3.94	4.25	H	1.50 TYP.	
C	1.40	1.60	J	3.00 TYP.	
D	2.25	2.60	K	0.32	0.52
E	1.55 TYP.		L	0.35	0.44
F	0.89	1.20			

## Mounting Pad Layout



## ABSOLUTE MAXIMUM RATINGS ( $T_A=25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>1</sup> @ $V_{GS}=10\text{V}$	$T_A=25^{\circ}\text{C}$	3.5	A
	$T_A=70^{\circ}\text{C}$	2.8	A
Pulsed Drain Current <sup>3</sup>	$I_{DM}$	10	A
Power Dissipation	$T_A=25^{\circ}\text{C}$	1.5	W
Operating Junction & Storage Temperature	$T_J, T_{STG}$	-65~150	$^{\circ}\text{C}$
Thermal Resistance Rating			
Maximum Thermal Resistance from Junction-Ambient <sup>1</sup>	$R_{\theta JA}$	$t \leq 10\text{s}, 50$	$^{\circ}\text{C/W}$
		Steady State, 85	
Maximum Thermal Resistance from Junction-Ambient <sup>2</sup>	$R_{\theta JA}$	135	
Maximum Thermal Resistance from Junction-Case <sup>1</sup>	$R_{\theta JC}$	36	

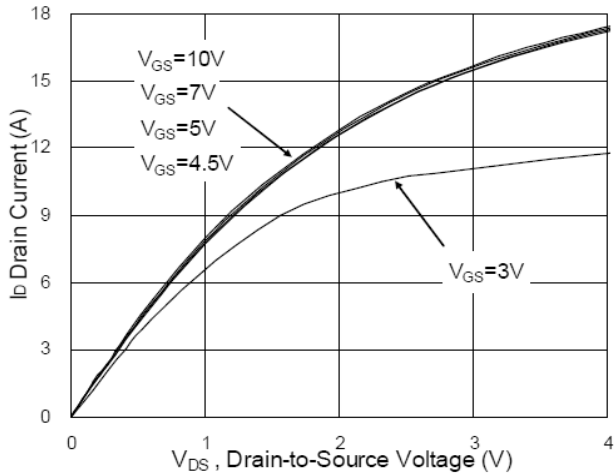
**ELECTRICAL CHARACTERISTICS** (T<sub>J</sub>=25°C unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	100	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> =250μA	
Gate Threshold Voltage	V <sub>GS(th)</sub>	1	-	2.5	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	
Forward Transfer conductance	g <sub>fs</sub>	-	4	-	S	V <sub>DS</sub> =5V, I <sub>D</sub> =2A	
Gate-Source Leakage Current	I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±20V	
Drain-Source Leakage Current	I <sub>DSS</sub>	T <sub>J</sub> =25°C	-	-	1	μA	V <sub>DS</sub> =80V, V <sub>GS</sub> =0
		T <sub>J</sub> =55°C	-	-	10		V <sub>DS</sub> =80V, V <sub>GS</sub> =0
Static Drain-Source On-Resistance <sup>4</sup>	R <sub>DS(ON)</sub>	-	-	170	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =2.6A	
		-	-	200		V <sub>GS</sub> =5V, I <sub>D</sub> =1.7A	
Total Gate Charge	Q <sub>g</sub>	-	20	-	nC	I <sub>D</sub> =6A V <sub>DS</sub> =50V V <sub>GS</sub> =10V	
Gate-Source Charge	Q <sub>gs</sub>	-	4	-			
Gate-Drain ("Miller") Charge	Q <sub>gd</sub>	-	5	-			
Turn-On Delay Time	T <sub>d(on)</sub>	-	17.3	-	nS	V <sub>DD</sub> =50V I <sub>D</sub> =1A V <sub>GS</sub> =10V R <sub>G</sub> =3.3Ω R <sub>D</sub> =50Ω	
Rise Time	T <sub>r</sub>	-	2.8	-			
Turn-Off Delay Time	T <sub>d(off)</sub>	-	50	-			
Fall Time	T <sub>f</sub>	-	2.8	-			
Input Capacitance	C <sub>iss</sub>	-	1077	-	pF	V <sub>GS</sub> =0 V <sub>DS</sub> =15V f=1MHz	
Output Capacitance	C <sub>oss</sub>	-	46	-			
Reverse Transfer Capacitance	C <sub>rss</sub>	-	32	-			
<b>Source-Drain Diode</b>							
Continuous Source Current <sup>1</sup>	I <sub>S</sub>	-	-	3.5	A		
Pulsed Source Current <sup>3</sup>	I <sub>SM</sub>	-	-	10	A		
Diode Forward Voltage <sup>4</sup>	V <sub>SD</sub>	-	-	1.2	V	I <sub>S</sub> =3.5A, V <sub>GS</sub> =0V	
Reverse Recovery Time	t <sub>rr</sub>	-	26	-	nS	I <sub>F</sub> =6A, dl/dt=100A/μs, T <sub>J</sub> =25°C	
Reverse Recovery Charge	Q <sub>rr</sub>	-	15	-	nC		

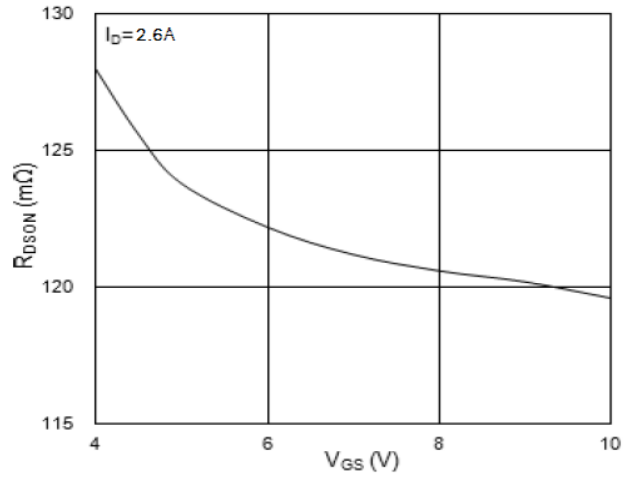
Notes:

1. Surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2oz copper.
2. When mounted on Min. copper pad.
3. Pulse width limited by Max. junction temperature.
4. Pulse width≤300us, duty cycles≤2%.

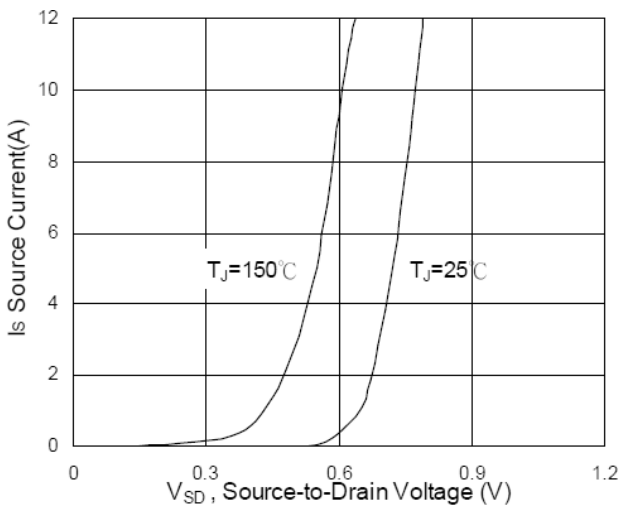
**CHARACTERISTIC CURVES**



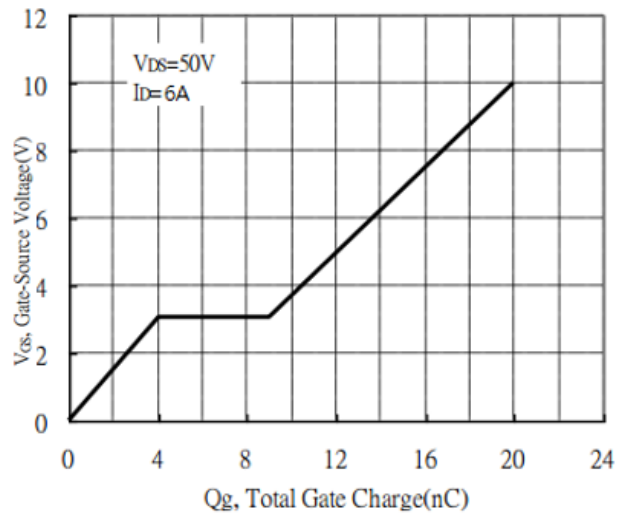
**Fig.1 Typical Output Characteristics**



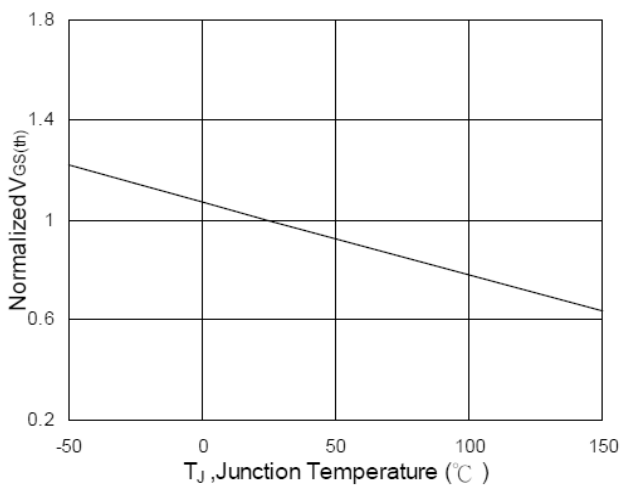
**Fig.2 On-Resistance vs. Gate-Source**



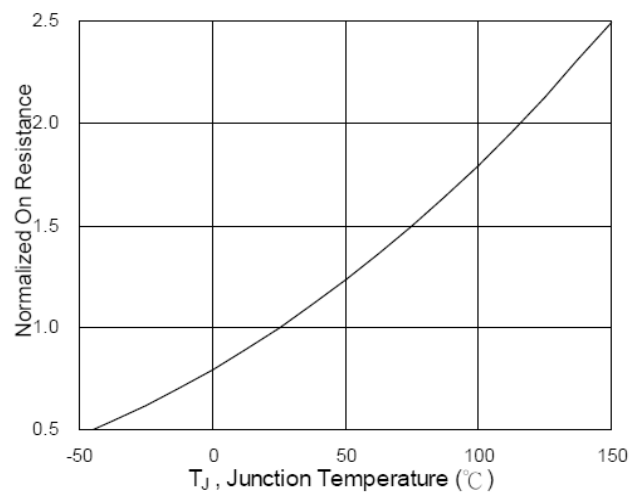
**Fig.3 Forward Characteristics Of Reverse**



**Fig.4 Gate-Charge Characteristics**

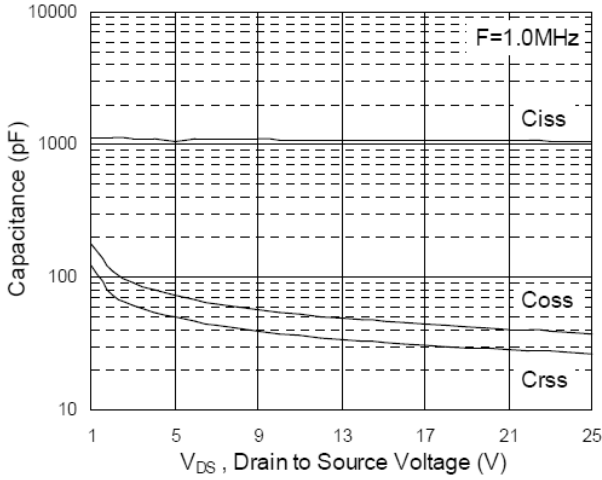


**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**

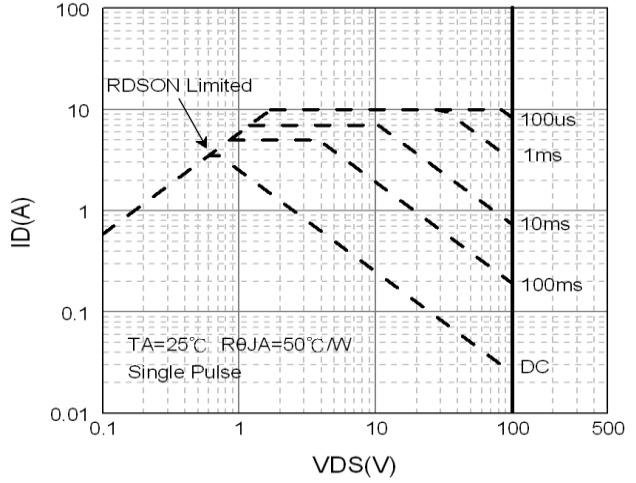


**Fig.6 Normalized  $R_{DS(ON)}$  vs.  $T_J$**

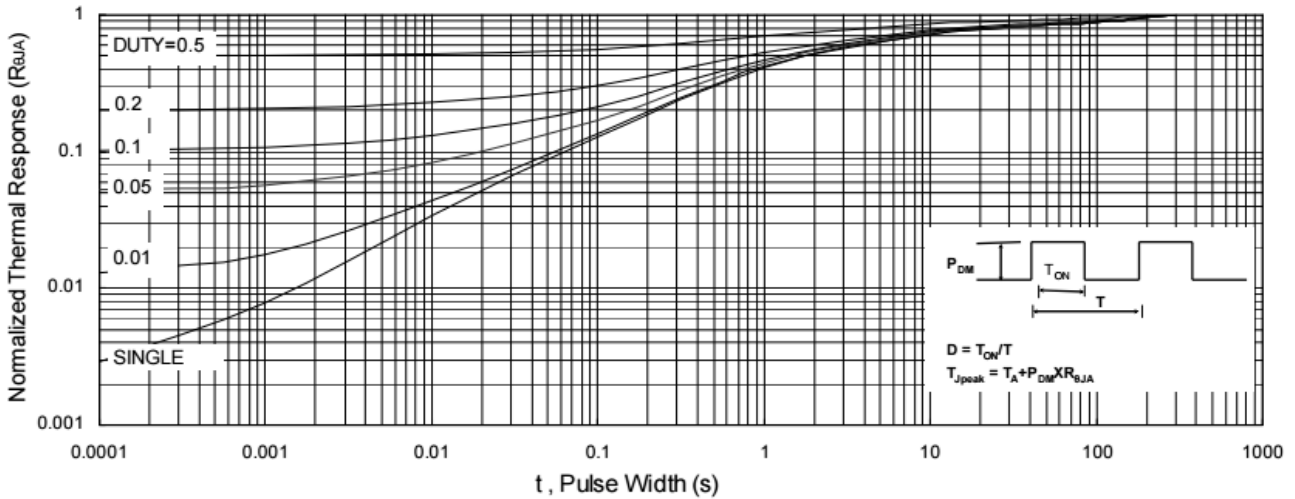
**CHARACTERISTIC CURVES**



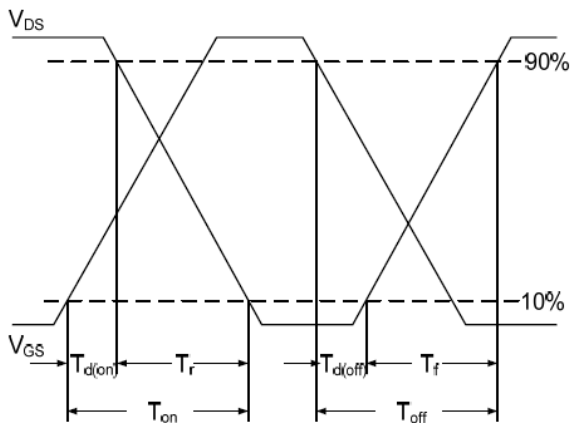
**Fig.7 Capacitance**



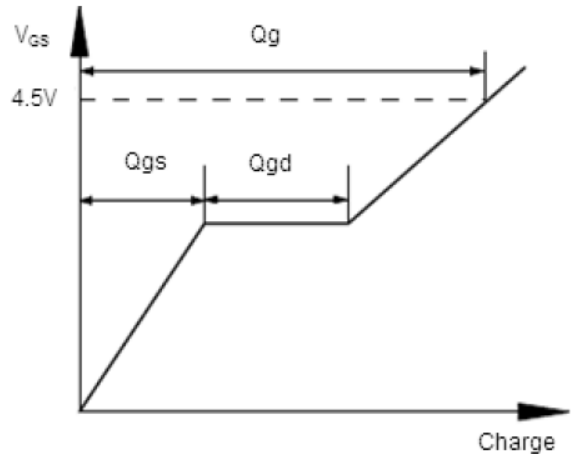
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**



**Fig.10 Switching Time Waveform**



**Fig.11 Gate Charge Waveform**